
Poenotena arhitektura OPC - 3. del: Model naslovnega prostora (IEC 62541-3:2010)

OPC unified architecture - Part 3: Address space model (IEC 62541-3:2010)

OPC Unified Architecture - Teil 3: Adressraummodell (IEC 62541-3:2010)

Architecture unifiée OPC -- Partie 3: Modèle d'espace d'adressage (CEI 62541-3:2010)

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(IEC 62541-3:2010)**

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Partie 3: Modèle d'espace d'adressage
(CEI 62541-3:2010)

OPC Unified Architecture -
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(IEC 62541-3:2010)

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Foreword

The text of document 64E/160/FDIS, future edition 1 of IEC 62541-3, prepared by SC 65E, Devices and integration in enterprise systems, of IEC TC 65, Industrial-process measurement, control and automation, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 62541-3 on 2010-10-01.

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Annex ZA has been added by CENELEC.

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Annex ZA (normative)

Normative references to international publications with their corresponding European publications

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

Publication	Year	Title	EN/HD	Year
IEC 62541-4	200X ¹⁾	OPC unified architecture - Part 4: Services	EN 62541-4	200X ²⁾
IEC 62541-5	200X ¹⁾	OPC unified architecture - Part 5: Information model	EN 62541-5	200X ²⁾
IEC 62541-6	200X ¹⁾	OPC unified architecture - Part 6: Mappings	EN 62541-6	200X ²⁾
IEC 62541-8	200X ¹⁾	OPC unified architecture - Part 8: Data access	EN 62541-8	200X ²⁾
IEC/TR 62541-1	-	OPC unified architecture - Part 1: Overview and concepts	CLC/TR 62541-1	-
ISO/IEC 10918-1	-	Information technology - Digital compression and coding of continuous-tone still images: Requirements and guidelines	-	-
ISO/IEC 15948	-	Information technology - Computer graphics and image processing - Portable Network Graphics (PNG) - Functional specification	-	-
ISO 639	Series	Codes for the representation of names of languages	-	-
ISO 3166	Series	Codes for the representation of names of countries and their subdivisions	EN ISO 3166	Series
IEEE 754	1985	Binary Floating-Point Arithmetic	-	-

¹⁾ To be published.

²⁾ At draft stage.

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

OPC UNIFIED ARCHITECTURE –

Part 3: Address Space Model

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Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

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A list of all parts of the IEC 62541 series, under the general title *OPC Unified Architecture*, can be found on the IEC website.